Search Notes

| Application/Control No. | Applicant(s)/Patent under Reexamination | - |
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| 09/729,262              | MURAKAWA, YASUSHI                       |   |
| Examiner                | Art Unit                                |   |
| Ellen C. Tran           | 2134                                    |   |

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| 713   | 201      | 6/1/2005 | ECT      |
| 713   | 153      | 6/1/2005 | ECT      |
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| SEARCH NOTES<br>(INCLUDING SEARCH STRATEGY)     |          |      |
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|   | DATE     | EXMR |
| USPTO, USPG, EPO, JPO,<br>DERWENT, IBM TECH DES | 6/1/2005 | ECT  |
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